October 2000

FDW2506P

SEMICONDUCTOR IM

Dual P-Channel 2.5V Specified PowerTrench[®] MOSFET

General Description

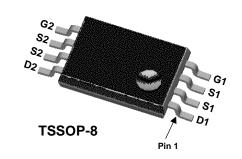
This P-Channel 2.5V specified MOSFET is a rugged gate version of Fairchild's Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (2.5V - 12V).

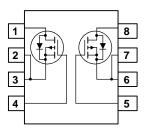
Applications

- Load switch
- Motor drive
- DC/DC conversion
- Power management

Features

- -5.3 A, -20 V, $R_{DS(ON)} = 0.022 \ \Omega \ @ V_{GS} = -4.5 \ V.$ $R_{DS(ON)} = 0.033 \ \Omega \ @ V_{GS} = -2.5 V.$
- Extended V_{GSS} range (±12V) for battery applications
- Low gate charge
- + High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- Low profile TSSOP-8 package





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		-20	V
V _{GSS}	Gate-Source Voltage		±12	V
ID	Drain Current – Continuous	(Note 1)	-5.3	A
	- Pulsed		-30	
P _D	Power Dissipation for Single Operation	(Note 1a)	1.0	W
		(Note 1b)	0.6	
T_J, T_{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C
Therma	al Characteristics			
R _{0JA}	Thermal Resistance, Junction-to-Ambient	(Note 1a)	125	°C/W

2506P FDW2506P 13" 12mm	Device Marki	ng Device	Reel Size	Tape width	Quantity
	2506P	FDW2506P	13"	12mm	2500 units

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics		•	•	•	
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = -250 \mu\text{A}$	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250 \ \mu\text{A}$, Referenced to 25°C		-12		mV/∘C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}} = -16 \text{ V}, V_{\text{GS}} = 0 \text{ V}$			-1	μA
I _{GSSF}	Gate–Body Leakage, Forward	$V_{GS} = -12 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			-100	nA
I _{GSSR}	Gate–Body Leakage, Reverse	$V_{GS} = 12 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
On Char	acteristics (Note 2)			•	•	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	-0.6	-0.8	-1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = -250 µA, Referenced to 25°C		3		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -5.3 \text{ A}$ $V_{GS} = -2.5 \text{ V}, I_D = -4.4 \text{ A}$ $V_{GS} = -4.5 \text{ V}, I_D = -5.3 \text{ A}, T_I = 125^{\circ}\text{C}$		0.018 0.026 0.023	0.022 0.033 0.035	Ω
I _{D(on)}	On–State Drain Current		-30			А
g fs	Forward Transconductance	$V_{DS} = -5 V$, $I_D = -5.3 A$		24		S
Dvnamio	Characteristics					
Ciss	Input Capacitance			1015		pF
C _{oss}	Output Capacitance	$V_{\rm DS} = -10 \text{ V}, V_{\rm GS} = 0 \text{ V},$		446		pF
C _{rss}	Reverse Transfer Capacitance	f = 1.0 MHz		118		pF
Switchir	g Characteristics (Note 2)	•				
t _{d(on)}	Turn–On Delay Time	$V_{DD} = -5 V$, $I_D = -1 A$,		13	23	ns
tr	Turn–On Rise Time	$V_{GS} = -4.5 \text{ V}, \qquad \text{R}_{\text{GEN}} = 6 \Omega$		17	31	ns
t _{d(off)}	Turn–Off Delay Time			75	120	ns
t _f	Turn–Off Fall Time			38	61	ns
Qg	Total Gate Charge	$V_{DS} = -10V, \qquad I_D = -5.3 \text{ A},$		21	34	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = -4.5 V$		4.5		nC
Q _{gd}	Gate-Drain Charge]		6		nC
Drain-S	ource Diode Characteristics	s and Maximum Ratings				
Is	Maximum Continuous Drain–Sourc				-0.83	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = -0.83 \text{ A} \text{ (Note 2)}$		-0.7	-1.2	V

Notes:

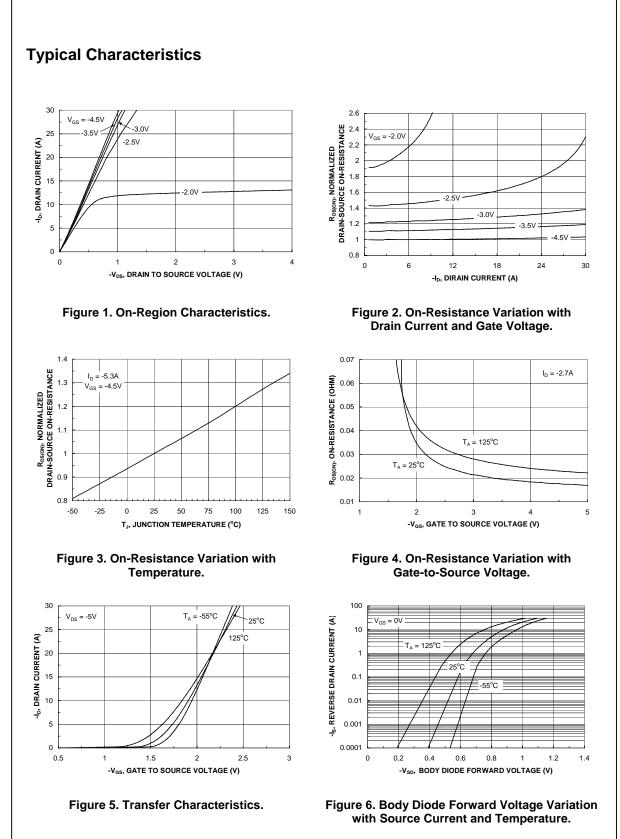
1. R_{eJA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{eJC} is guaranteed by design while R_{eCA} is determined by the user's board design.

a) $\rm R_{\theta JA}$ is 125°C/W (steady state) when mounted on a 1 inch² copper pad on FR-4.

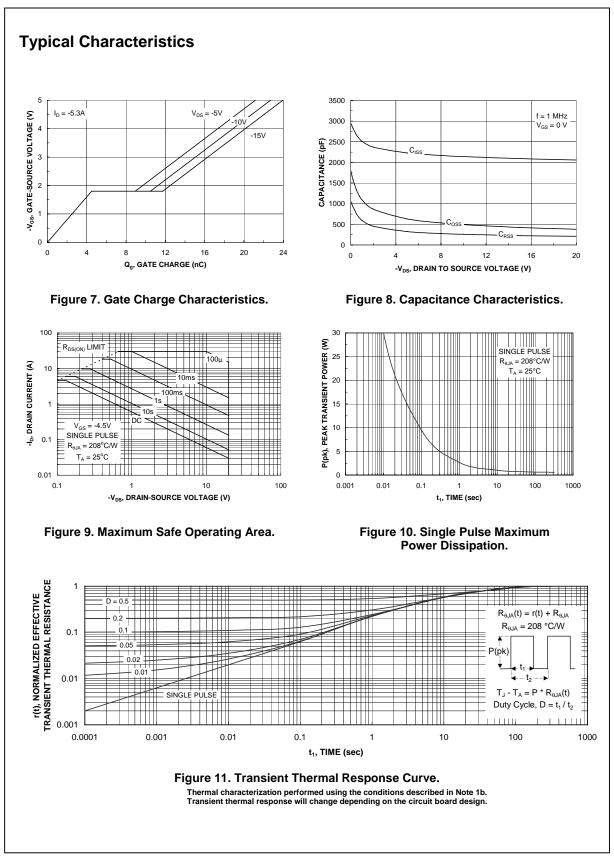
b) $R_{\theta JA}$ is 208°C/W (steady state) when mounted on a minimum copper pad on FR-4.

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

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